

Interpretation of Cs behaviour in waste reduction process by X-ray imaging and position sensitive XAFS methods



Quantum Beam Science Directorate, JAEA Y.Okamoto

The aim of this study

- (1) X-ray imaging observation of soil at heating
- (2) Cs L₃-edge imaging XAFS analysis in clay mineral/soil
- (3) Imaging XAFS analysis of Cs in flying ash

Remarkable technique of this study

- (1) XAFS technique with position sensitivity
- (2) In-situ X-ray imaging at heating
- (3) Separation of Cs and Ti in the Cs L_3 -edge XAFS spectra

Layout of the **normal XAFS** measurement



Intensity obtained from the normal XAFS is <u>an averaged</u> value corresponding to the X-ray beam size

shaped by the slit.





From EXAFS function, we may identify the kind of clay minerals which Cs adsorbed.

Layout of imaging and imaging XAFS measurement



(1) X-ray imaging observation of soil at heating

Composition of the soil (Kajiuchi, litate-Vill. Fukushima)

Comp.	wt%	mp:°C	
Na ₂ O	1.82	1132	
MgO	0.72	2830	
Al_2O_3	16.75	2054	
SiO ₂	61.17	1710	
K ₂ O	0.82	*763	
CaO	1.35	2900	
TiO ₂	0.46	1800	
Fe_2O_3	4.26	*1565	
basicity	0.022	* decompo	se

Heating the Cs-adsorbed soil under air atmosphere to 1500°C



(Continue)

Cs distribution maps obtained from imaging XAFS data (Note: These are NOT CCD images)



Summary of Cs behavior at some heating experiments

Common experimental condition:

- (1) under air atmosphere (2) Max. temperature 1500° C
- ③ using Cs K-edge

Materials (Cs-adsorbed)	Additives (No cesium)	Result after the heating
Soil	none	Most cesium remained
Kaolinite	Vermiculite	Most cesium remained
Ash	none	Most cesium disappeared
Ash	Kaolinite	Some cesium remained
Ash	Vermiculite	Most cesium remained

Further works are in progress

(2) L₃-edge imaging XAFS analysis of Cs in clay mineral/soil

Edge	E(keV)
К	35.985
L_1	5.714
L ₂	5.359
L ₃	5.012

Why we use L₃-edge in addition to K-edge ?

We should choose which absorption edge is appropriate, depending on the condition of samples and the purpose of analysis.

For example,

(a) In the heating experiment, we haveto use a sample vessel. Therefore, theK-edge (higher energy) is better.

(b) In the experiment of fly ash, we handle very thin film. Therefore, the L_3 -edge (lower energy) is better.



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We have had a serious problem in the Cs L₃-edge XAFS

Titanium(Ti) is contained in most environmental samples like soil.

Element	Abs. edge	Fluorescence
Ti K	4.965keV	4.286keV(Kα)
Cs L ₃	5.012keV	4.510keV(Lα)

The absorption edge energy of Cs L_3 -edge is close to that of Ti K-edge.

It is very difficult or impossible to use the Cs L_3 -edge for normal XAFS measurement of soil and ash. Most researchers <u>GIVE UP using L_3 -</u> <u>edge</u> for chemical analysis of cesium.



The distribution of Cs in the soil sample does not necessarily accord with that of Ti.



The imaging XAFS technique make it possible to use Cs L_3 -edge in XAFS analysis of environmental samples.

(3) Imaging XAFS analysis of Cs in fly ash

Fly ash was collected on Al foil by using the DEKATI-ELPI+ impactor



Typical example of Fly ash on aluminum foil

Imaging XAFS of Cs in the fly ash

Movie: CCD images for X-ray energy scan from 4.85 to 5.40keV

Note color changes at $5.012 \text{keV}(L_3 \text{-edge})$ and $5.359 \text{keV}(L_2 \text{-edge})$





Information on Cs mapping can be available from imaging XAFS analysis.

We can evaluate quantity of cesium and size dependence of fly ash.

In addition, chemical form of cesium corresponding to each spot can be identified by obtaining imaging XAFS spectrum.



Summary

1. In-situ X-ray imaging observation at heating process was demonstrated in this presentation. Such kinds of works are still in progress in the synchrotron facility.

2. Imaging XAFS technique has position sensitivity. We showed possibility of Cs L_3 -edge imaging XAFS technique.

3. As a typical example of Cs L_3 -edge analysis, we introduced imaging XAFS work on the fly ash. We are now searching appropriate condition of incinerator operation.

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